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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Wobbe et al. Art Unit : 3628
Serial No. : 10/749,808 Examiner : Unknown
Filed : December 31, 2003 Conf. No. : 5346
Title : SYSTEM AND METHOD OF MASTER DATA MANAGEMENT USING RFID
TECHNOLOGY

MAIL STOP AMENDMENT

Commissioner for Patents
P.O. Box 1450
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INFORMATION DISCLOSURE STATEMENT

Applicants request consideration of the references listed on the attached PTO-1449 form.
Under 37 C.F.R. § 1.98 (a)(2)(ii), only copies of foreign patent documents and/or non-patent literature are enclosed.

This statement is being filed within three months of the filing date of the application or before the receipt of a first Office Action on the merits. Please apply any charges or credits to Deposit Account No. 06-1050.

Respectfully submitted,

Date: 9/7/06

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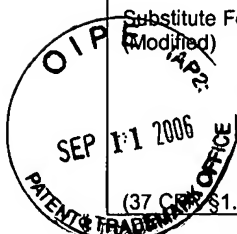
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Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 13907-065001	Application No. 10/749,808
Information Disclosure Statement by Applicant (Use several sheets if necessary)		Applicant Wobbe et al.	
		Filing Date December 31, 2003	Group Art Unit 3628

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	US 5,758,031	05/26/1998	De Silva			
	AB	US 6,842,881	01/11/2005	Croke et al.			

Foreign Patent Documents or Published Foreign Patent Applications							
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation Yes No

Other Documents (include Author, Title, Date, and Place of Publication)		
Examiner Initial	Desig. ID	Document

Examiner Signature	Date Considered
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EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.